## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CHEN ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,949,511	09-1999	Park, Jong Jin	349/139
*	В	US-6,141,078	10-2000	Morii et al.	349/155
*	С	US-6,657,699	12-2003	Matsumoto, Kimikazu	349/156
*	D	US-5,338,240	08-1994	Kim, Jin Young	445/24
*	E	US-6,243,154	06-2001	You et al.	349/141
*	F	US-6,130,739	10-2000	Shimoshikiryo et al.	349/182
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

NON-FAILNI DOCUMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	х						

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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